

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination	
		10/719,743	NEW ET AL.	
		Examiner	Art Unit	
		Hai L. Nguyen	2816	

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
327	158	327	161 261
INTERNATIONAL CLASSIFICATION			
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Hai L. Nguyen (Assistant Examiner)		5/09/2006 (Date)	TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner)
Anita Smith (Legal Instruments Examiner)		5/15/06 (Date)	(Date)
Total Claims Allowed: 23			
		O.G. Print Claim(s)	O.G. Print Fig.
		1	2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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